Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/709,824	SHIUNG, DAVID
Examiner	Art Unit
Tan V. Mai	2193

SEARCHED				
Class	Subclass	Date	Examiner	
708	270-272	6/18/2007	MAI	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	6/18/2007	MAI	